Searc	ch Notes	

_	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/037,755	CHO ET AL.	
	Examiner	Art Unit	
	Erin M. File	2611	

	SEARCHED		
Class	Subclass	Date	Examiner
375	130	5/3/2006	EMF
375	140	5/3/2006	EMF
375	141	5/3/2006	EMF
375	146	5/3/2006	EMF
370	208	5/3/2006	EMF
370	209	5/3/2006	EMF
370	329	5/3/2006	EMF
370	335	5/3/2006	EMF_
370	341	5/3/2006	EMF
370	342	5/3/2006	EMF
370	431	5/3/2006	EMF
370	441	5/3/2006	EMF
370	491	5/3/2006	EMF
370	500	5/3/2006	EMF

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
		<u> </u>	

SEARCH NOT (INCLUDING SEARCH))
	DATE	EXMR
EAST US PAT, USPGPUB, EPO, JPO DERWENT, IBM (text search only—see search history printout)	5/3/2006	EMF
Conversation with J. Correlius AU2611 for claim understanding and subclass search suggestions	5/3/2006	EMF
Conversation with Ajit Patel, AU2616 for 370 subclass search suggestions	5/3/2006	EMF ·